Poster Sessions

measuring the variations of lattice constants of iso-strained substrate layers at different penetration depths. This method is now applied to investigate the strain field of quantum dots nano-structures of FeSi2/Si. Choosing one secondary diffracted beam along the interface (parallel to the surface of the substrate) between the quantum dots and the Si substrate, the diffraction images of the secondary diffraction, recorded on a charge coupled device (CCD), provide the information of the interfacial structures. The three-dimensional strain and a theoretical calculation of X-ray scattering from quantum dots at the Bragg-surface diffraction geometry based on the dynamical theory will be also reported.

Keywords: FeSi₂, interface, diffraction

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Oxygen-induced D03-sublattice disorder at the Fe₃Al(110) surface

Vedran Vonk, Claus Ellinger, Navid Khorshidi, Alina Vlad, Andreas Stierle, Helmut Dosch

Max Planck Institute for Metals Research, Dosch Department, Heisenbergstrasse 3, Stuttgart, Baden-Wuertemberg, 70569, Germany, E-mail:vonk@mf.mpg.de

Alloys of Fe and Al form promising materials for high-temperature light-weight replacements of steel [1]. However, for their use in real applications, the understanding and control of the oxidation behaviour is crucial [2]. Here, the atomic structures of the clean and oxidized Fe₃Al(110) surface are studied by in situ surface X-ray diffraction using synchrotron radiation. The results for the clean surface demonstrate that the topmost atomic layer exhibits in-plane B2 order, with a D03 bulk beneath it. Upon oxidation at 10⁻⁶ mbar of molecular oxygen at a temperature of 573 K, the D03 long-range order in the near-surface region disappears completely, without affecting the surface roughness nor the crystallinity. At the same time, a smooth 8.4(3) \cong AA \cong thin aluminium-oxide layer is formed on the surface, as concluded by complementary X-ray reflectivity and Auger Electron Spectroscopy measurements. These results can be understood by preferential surface seggregation in combination with a high affinity of Al for oxygen. These findings are very important for real applications of iron-aluminides, since their physical properties depend stronly on the composition and the resulting ordering. The present result of oxygen-induced Al-depletion is expected to result in a stronger and less brittle selvedge than the bulk beneath, which has important implications for the processing of these materials.

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Keywords: oxidation, binary metal surfaces, surface X-ray diffraction

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PTRF-XAFS investigations on the interaction between metal and the oxide support

<u>Kiyotaka Asakura</u>¹, Yuichiro Koike², Wang-Jae Chun³, Masaharu Nomura²

¹Hokkaido University, Catalysis Research Center, kita 21-10, Sapporo, Hokkaido, 001-0021, Japan, ²Photon Factory, Institute of Materials Structure Science, Oho 1-1 Tsukuba, 305-0801, Japan, ³International Christian University, Isawa 3-10-2, Mitaka, Tokyo, 181-8585, Japan, E-mail:askr@cat.hokudai.ac.jp

Metal-oxide interaction plays an important role in catalysts, sensors, electric devices, optical materials and so on. Single crystal oxide systems are used as model system and a $TiO_2(110)$ surface is most widely studied. We have investigated Ni on TiO_2 (110) using polarization-dependent total reflection fluorescence X-ray absorption fine structure(TPRF-XAFS) to clarify the real metal-oxide interaction directly. XAFS measurements were carried out at BL9A in Photon Factory. Ni was deposited on the TiO_2 (110) by resistive heating under

UHV conditions. Polarization dependent measurements were carried out in 3 different directions. Ni K-edge XAFS oscillations as shown in Fig. 1 indicated the presence of large number of Ni-O bonds especially in the [11b0] direction in addition to the Ni-Ni interaction. We proposed the cluster structure as depicted in Fig.1d. In this structure Ni atoms in the cluster was arranged in a Ni (110)-like structure parallel to the surface. The one-atomic layer Ni clusters was stabilized by the interaction with oxygen atoms.



Keywords: X-ray absorption fine structure, surface structure, oxide surfaces

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Total reflection of X-rays due to diffraction

Jun Kawai, Shinsuke Kunimura

Kyoto University, Department of Materials Science and Engineering, Sakyo-ku, Kyoto, Kyoto, 606-8501, Japan, E-mail : jun.kawai@materials. mbox.media.kyoto-u.ac.jp

Total reflection of x-rays due to diffraction. In a popular X-ray diffraction book [1], the diffraction and the reflection are treated as completely different physical phenomena: (1) The diffracted X-rays by the crystal are formed by scattering from all the atoms irradiated by the incident X-rays, but visible light is only reflected by the surface thin layer. (2) Monochromatic X-ray diffraction by a crystal takes place at the Bragg angle, but the visible light reflection takes place at any angle. (3) The reflection by a mirror is about 100 %, and the intensity does not decrease due to the reflection, but the diffracted X-ray intensity is extremely weaker than the incident X-rays. However, I would like to claim that the X-ray diffraction and the X-ray total reflection, which is similar to the visible light specular reflection, are both diffraction phenomena. Takahashi and Nakatani have already claimed this at 1995 [2]. The consequence of the above discussion will be: (1) the total reflection intensity profile is the Darwin profile, which has been pointed out by Ref.[2]; (2) the critical angle of X-ray total reflection can be interpreted from the dynamical theory of X-ray diffraction. The fundamental of X-ray total reflection is important for the practical application of total reflection X-ray fluorescence for sub nanogram analysis [3]. Some applications of the X-ray specular reflection are also presented. References

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